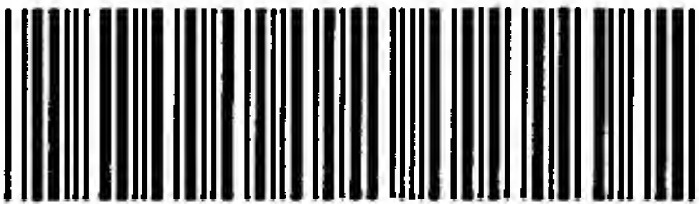


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/993,985	DUPERRAY, DAVID BENOIT DIDIER	
	Examiner	Art Unit	
	Jia W. Lu	2634	

SEARCHED			
Class	Subclass	Date	Examiner
375	297	12/13/2005	JL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	297	12/13/2005	JL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
ALL EAST DATABASES	12/13/2005	JL